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FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 10 μ A (Max.) @ $V_{DS} = 100V$
- Lower $R_{DS(ON)}$: 0.155 Ω (Typ.)

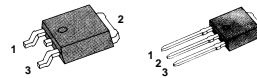
$$BV_{DSS} = 100 V$$

$$R_{DS(on)} = 0.2 \Omega$$

$$I_D = 8.4 A$$

D-PAK

I-PAK



1. Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V_{DSS}	Drain-to-Source Voltage	100	V
I_D	Continuous Drain Current ($T_C=25^\circ C$)	8.4	A
	Continuous Drain Current ($T_C=100^\circ C$)	5.3	
I_{DM}	Drain Current-Pulsed ①	34	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy ②	141	mJ
I_{AR}	Avalanche Current ①	8.4	A
E_{AR}	Repetitive Avalanche Energy ①	3.2	mJ
dv/dt	Peak Diode Recovery dv/dt ③	6.5	V/ns
P_D	Total Power Dissipation ($T_A=25^\circ C$) *	2.5	W
	Total Power Dissipation ($T_C=25^\circ C$)	32	W
	Linear Derating Factor	0.26	W/ $^\circ C$
T_J, T_{STG}	Operating Junction and Storage Temperature Range	- 55 to +150	$^\circ C$
T_L	Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	3.9	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient *	--	50	
$R_{\theta JA}$	Junction-to-Ambient	--	110	

* When mounted on the minimum pad size recommended (PCB Mount).

Electrical Characteristics ($T_{\theta}=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	100	--	--	V	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.12	--	V/ $^{\circ}\text{C}$	$I_D=250\mu\text{A}$ See Fig 7
$V_{GS(th)}$	Gate Threshold Voltage	2.0	--	4.0	V	$V_{DS}=5\text{V}, I_D=250\mu\text{A}$
I_{GSS}	Gate-Source Leakage, Forward	--	--	100	nA	$V_{GS}=20\text{V}$
	Gate-Source Leakage, Reverse	--	--	-100		$V_{GS}=-20\text{V}$
I_{DSS}	Drain-to-Source Leakage Current	--	--	10	μA	$V_{DS}=100\text{V}$
		--	--	100		$V_{DS}=80\text{V}, T_C=125^{\circ}\text{C}$
$R_{DS(on)}$	Static Drain-Source On-State Resistance	--	--	0.2	Ω	$V_{GS}=10\text{V}, I_D=4.2\text{A}$ ④
g_{fs}	Forward Transconductance	--	6.29	--	Ω	$V_{DS}=40\text{V}, I_D=4.2\text{A}$ ④
C_{iss}	Input Capacitance	--	370	480	pF	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	--	95	110		
C_{rss}	Reverse Transfer Capacitance	--	38	45		
$t_{d(on)}$	Turn-On Delay Time	--	14	40	ns	$V_{DD}=50\text{V}, I_D=9.2\text{A},$ $R_G=18\Omega$ See Fig 13 ④⑤
t_r	Rise Time	--	14	40		
$t_{d(off)}$	Turn-Off Delay Time	--	36	90		
t_f	Fall Time	--	28	70		
Q_g	Total Gate Charge	--	16	22	nC	$V_{DS}=80\text{V}, V_{GS}=10\text{V},$ $I_D=9.2\text{A}$ See Fig 6 & Fig 12 ④⑤
Q_{gs}	Gate-Source Charge	--	2.7	--		
Q_{gd}	Gate-Drain("Miller") Charge	--	7.8	--		

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_S	Continuous Source Current	--	--	8.4	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	--	--	34		
V_{SD}	Diode Forward Voltage ④	--	--	1.5	V	$T_J=25^{\circ}\text{C}, I_S=8.4\text{A}, V_{GS}=0\text{V}$
t_{rr}	Reverse Recovery Time	--	98	--	ns	$T_J=25^{\circ}\text{C}, I_F=9.2\text{A}$
Q_{rr}	Reverse Recovery Charge	--	0.34	--	μC	$di_F/dt=100\text{A}/\mu\text{s}$ ④

Notes ;

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
 ② $L=3\text{mH}, I_{AS}=8.4\text{A}, V_{DD}=25\text{V}, R_G=27\Omega$, Starting $T_J=25^{\circ}\text{C}$
 ③ $I_{SD} \leq 9.2\text{A}, di/dt \leq 300\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$, Starting $T_J=25^{\circ}\text{C}$
 ④ Pulse Test : Pulse Width = 250 μs , Duty Cycle $\leq 2\%$
 ⑤ Essentially Independent of Operating Temperature

Fig 1. Output Characteristics

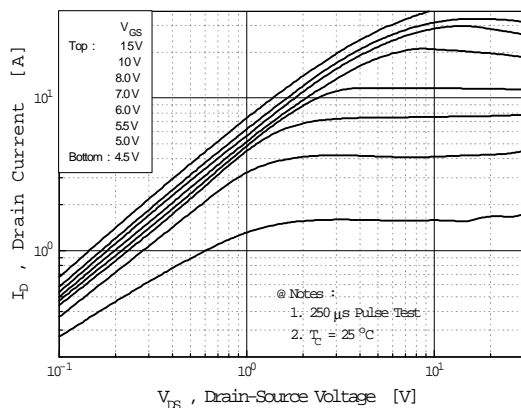


Fig 2. Transfer Characteristics

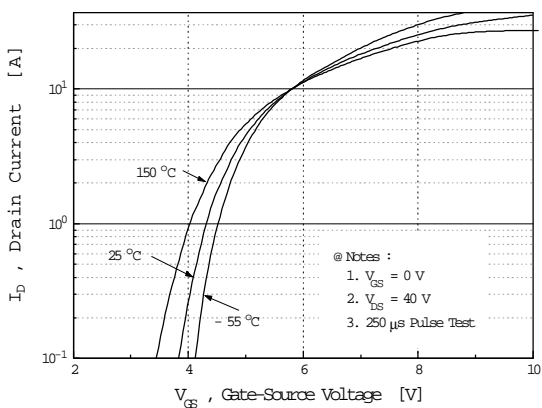


Fig 3. On-Resistance vs. Drain Current

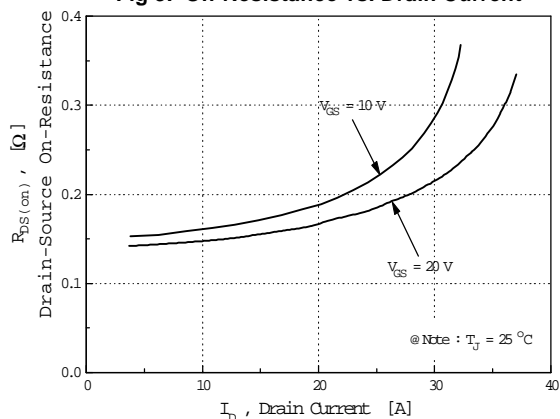


Fig 4. Source-Drain Diode Forward Voltage

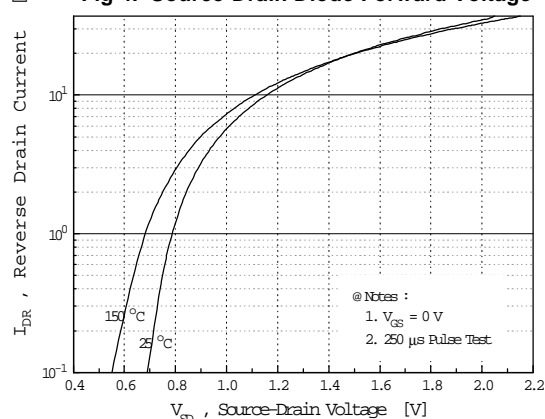


Fig 5. Capacitance vs. Drain-Source Voltage

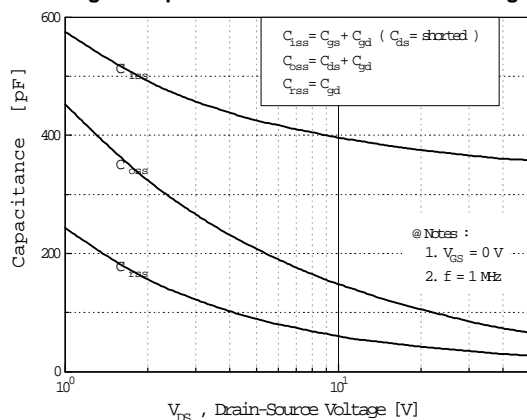
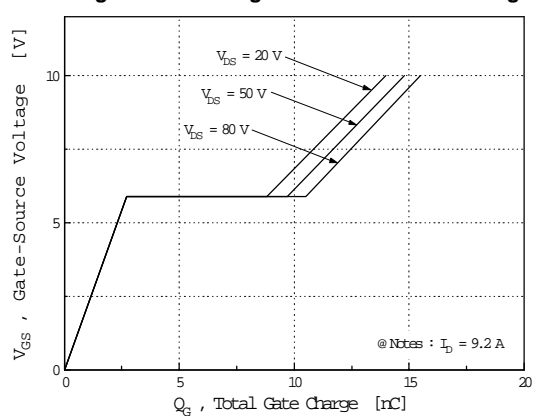


Fig 6. Gate Charge vs. Gate-Source Voltage



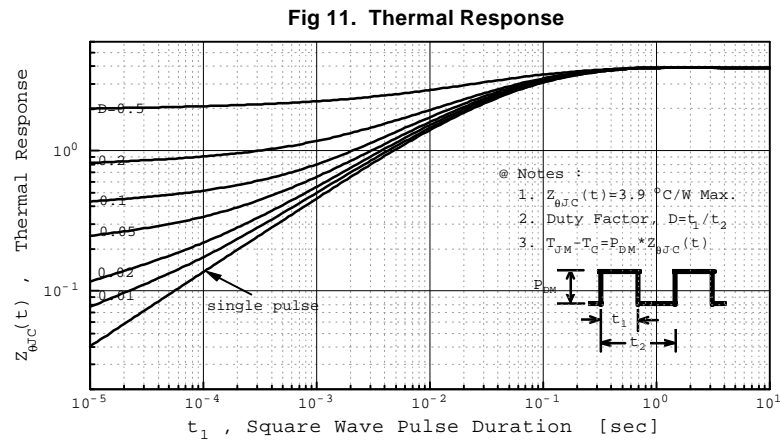
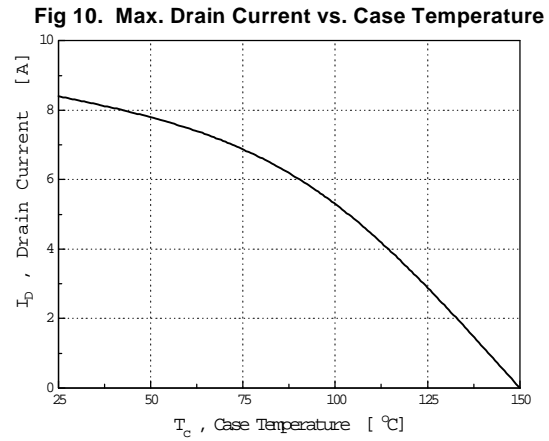
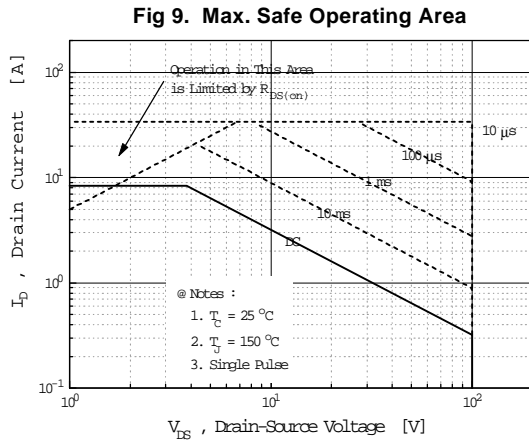
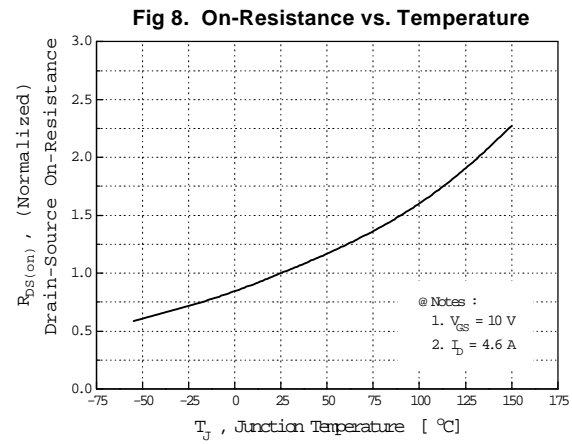
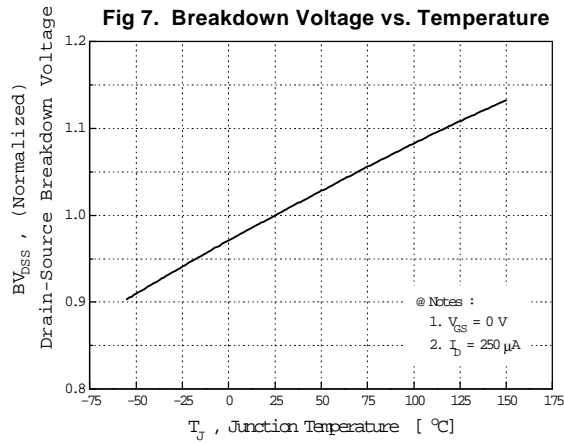


Fig 12. Gate Charge Test Circuit & Waveform

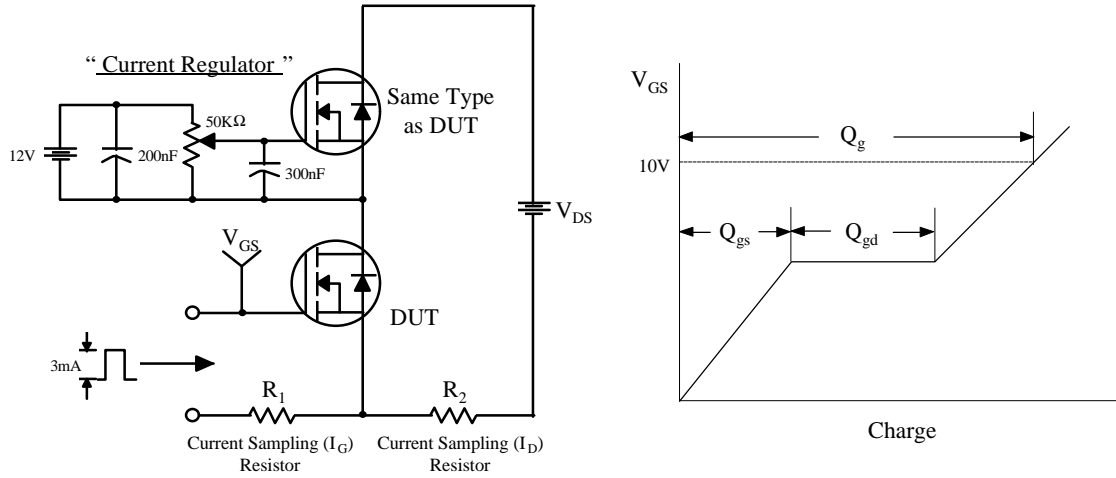


Fig 13. Resistive Switching Test Circuit & Waveforms

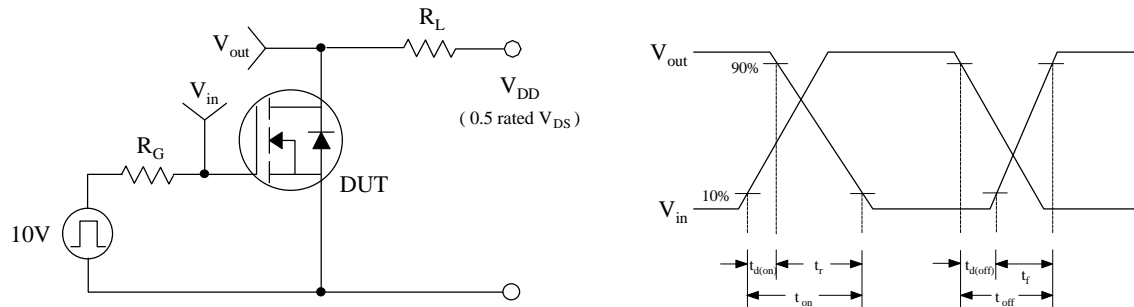


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

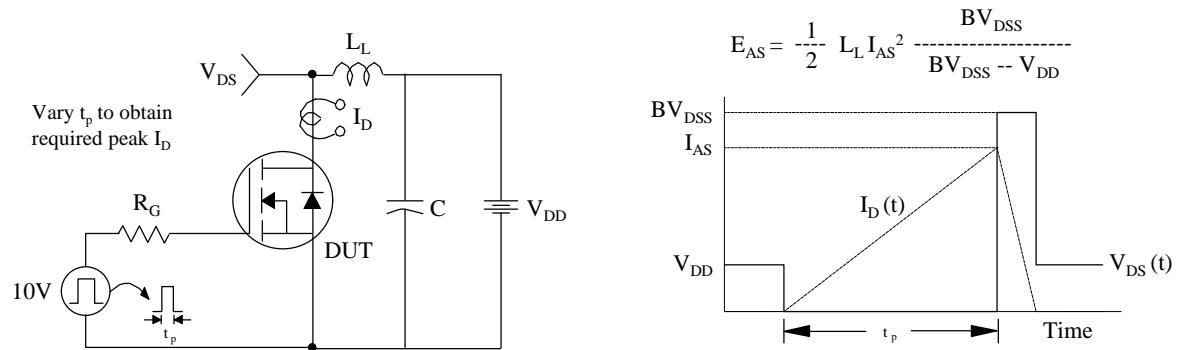
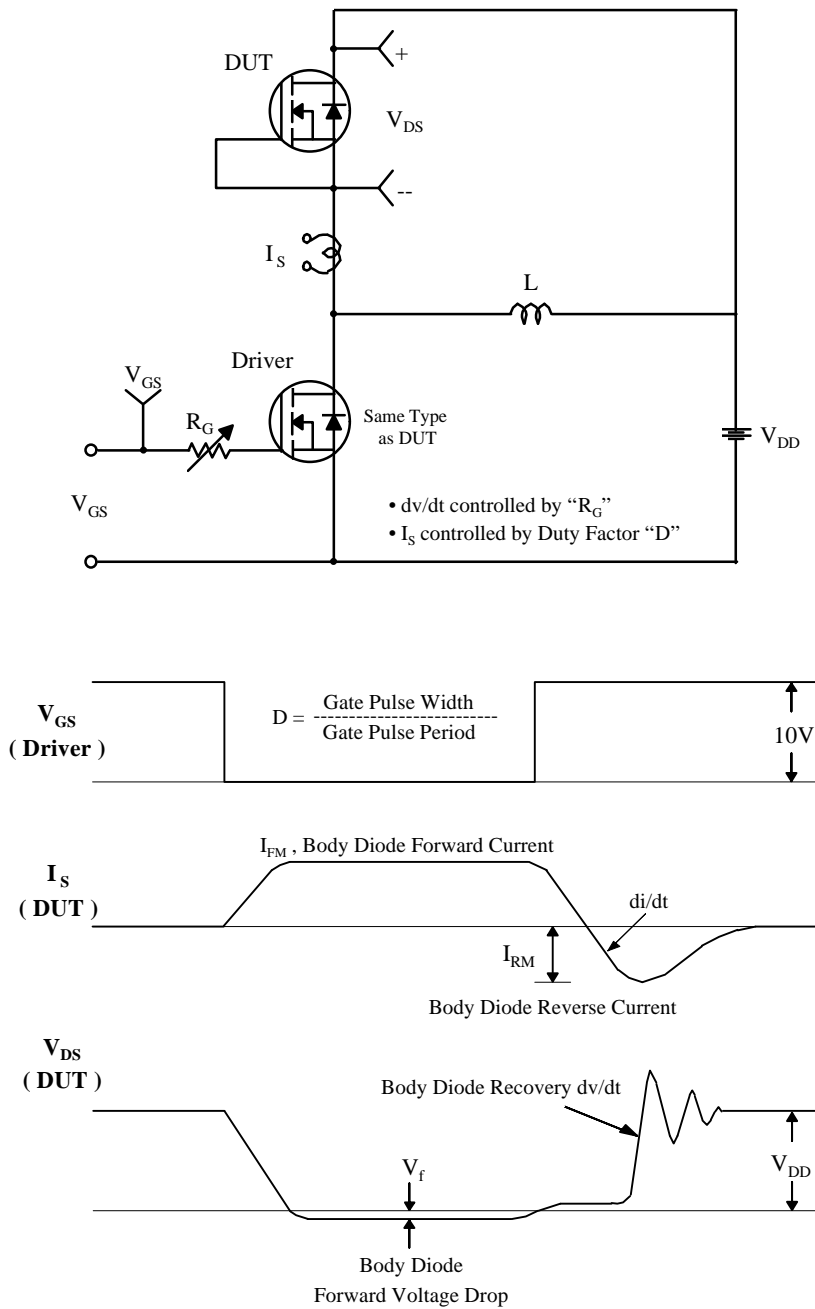


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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